



CE EMC Test Report

(Certificate of Conformity) For

Electromagnetic Interference

Of

Product : led moving head beam light

Trade Name :

LY-390A, LY-390B, LY-380A, LY-380B, LY-360A, Model Number : LY-360B, LY-90A, LY-90B, LY-108A, LY-108B, LY-108G, LY-120B, LY-120G, LY-75A, LY-75H, LY-60F, LY-60G, LY-35A.

Prepared for

GuangZhou Topsun Lighting Science and Technology Co., Ltd.

3th Floor, No.10 Taipingli South Street, Jiaoxin, Shijing Town, Baiyun District, Guangzhou, China

Prepared by

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TEST RESULT CERTIFICATION

••	GuangZhou Topsun Lighting Science and Technology Co., Ltd. 3th Floor,No.10 Taipingli South Street, Jiaoxin, Shijing Town, Baiyun District, Guangzhou, China	
Address	Baiyun District, Guangzhou, China	
Manufacturer's Name:	GuangZhou Topsun Lighting Science and Technology Co., Ltd.	
Address	3th Floor,No.10 Taipingli South Street, Jiaoxin, Shijing Town, Baiyun District, Guangzhou, China	
Product description		
Product name:	led moving head beam light	
Model and/or type reference :	LY-390A, LY-390B, LY-380A, LY-380B, LY-360A, LY-360B, LY-90A, LY-90B, LY-108A, LY-108B, LY-108G, LY-120B, LY-120G, LY-75A, LY-75H, LY-60F, LY-60G, LY-35A.	
Standards	EN 55015:2013 EN 61547:2009 EN 61000-3-2:2014 EN 61000-3-3:2013	
This device described above has been tested by CTB, and the test results show that the equipment under test (EUT) is in compliance with the 2004/108/EC requirements. And it is applicable only to the tested sample identified in the report.		
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Date of Test	
Date (s) of performance of tests:	22 May 2015~26 May 2015
Date of Issue:	27 May 2015
Test Result	Pass

Testing Engineer : Authorized Signatory :

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1. TEST SUMMARY

Test procedures according to the technical standards:

EMC Emission				
Standard	Test Item	Limit	Judgment	Remark
	Conducted Emission	Class B	PASS	
EN 55015:2013	Radiated Emission	Class B	PASS	
EN61000-3-2:2014	Harmonic Current Emission	Class C	PASS	
EN 61000-3-3:2013	Voltage Fluctuations & Flicker		PASS	
EMC Immunity				
Section EN 61547:2009	Test Item	Performance Criteria	Judgment	Remark
EN 61000-4-2:2009	Electrostatic Discharge	В	PASS	
EN 61000-4-3:2010	RF electromagnetic field	А	PASS	
EN 61000-4-4:2004+A1:2010	Fast transients	В	PASS	
EN 61000-4-5:2006	Surges	В	PASS	
EN 61000-4-6:2009	Injected Current	А	PASS	
EN 61000-4-8:2010	Power Frequency Magnetic Field	А	PASS	
EN 61000-4-11:2004	Volt. Interruptions Volt. Dips	B / C NOTE (2)	PASS	

NOTE:

- (1)" N/A" denotes test is not applicable in this Test Report
- (2) Voltage dip: 100% reduction Performance Criteria B
 Voltage dip: 30% reduction Performance Criteria C
- (3) For client's request and manual description, the test will not be executed.



1.1 TEST FACILITY

Shenzhen CTB Testing Technology Co., Ltd.

Add. : First floor, E building, Huayang Technology Industry Park, Gushu Village, Bao'an District, Shenzhen City, P.R.C

1.2 MEASUREMENT UNCERTAINTY

The reported uncertainty of measurement $y \pm U$, where expended uncertainty U is based on a standard uncertainty multiplied by a coverage factor of **k=2**, providing a level of confidence of approximately **95**%.

A. Conducted Measurement :

Test Site	Method	Measurement Frequency Range	U , (dB)	NOTE
CTBC01	ANSI	150 KHz ~ 30MHz	3.2	

B. Radiated Measurement :

Test Site	Method	Measurement Frequency Range	U , (dB)	NOTE
CTBA01	ANSI	30MHz ~ 1000MHz	4.7	
		1GHz ~6GHz	5.0	

2. GENERAL INFORMATION

2.1 GENERAL DESCRIPTION OF EUT

Equipment	led moving head beam light	
Model Name	LY-390A	
Serial No	LY-390B, LY-380A, LY-380B, LY-360A, LY-360B, LY-90A, LY-90B, LY-108A, LY-108B, LY-108G, LY-120B, LY-120G, LY-75A, LY-75H, LY-60F, LY-60G, LY-35A.	
Product Description	The EUT is led moving head beam light Operating frequency: N/A Connecting I/O port: N/A Based on the application, features, or specification exhibited in User's Manual, the EUT is considered as an ITE/Computing Device. More details of EUT technical specification, please refer to the User's Manual.	
Power Source	AC Voltage	
Power Rating	110V-240V~ 50-60Hz, 400W	



2.2 DESCRIPTION OF TEST MODES

To investigate the maximum EMI emission characteristics generates from EUT, the test system was pre-scanning tested base on the consideration of following EUT operation mode or test configuration mode which possible have effect on EMI emission level. Each of these EUT operation mode(s) or test configuration mode(s) mentioned above was evaluated respectively.

Pretest Mode	Description
Mode 1	On

For Conducted Test	
Final Test Mode	Description
Mode 1	On

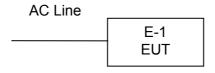
For Radiated Test	
Final Test Mode	Description
Mode 1	On

For EMS Test		
Final Test Mode	Description	
Mode 1	On	



2.3 DESCRIPTION OF TEST SETUP

Mode 1:







2.4 DESCRIPTION TEST PERIPHERAL AND EUT PERIPHERAL

The EUT has been tested as an independent unit together with other necessary accessories or support units. The following support units or accessories were used to form a representative test configuration during the tests.

Item	Equipment	Mfr/Brand	Model/Type No.	Series No.	Note
E-1	EUT			N/A	EUT

Item	Shielded Type	Ferrite Core	Length	Note

Note:

- (1) The support equipment was authorized by Declaration of Confirmation.
- (2) For detachable type I/O cable should be specified the length in cm in ^[]Length ^[] column.
- (3) "YES" means "shielded" "with core"; "NO" means "unshielded" "without core".

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2.5 MEASUREMENT INSTRUMENTS LIST

2.5.1 CONDUCTED TEST SITE

Item	Kind of Equipment	Manufacturer	Type No.	Serial No.	Calibrated until
1	LISN	R&S	ENV216	101313	Jul. 06, 2015
2	LISN	EMCO	3816/2	00042990	Jul. 06, 2015
3	50Ω Switch	ANRITSU CORP	MP59B	6200983704	Jul. 06, 2015
4	Test Cable	N/A	C01	N/A	Jul. 06, 2015
5	Test Cable	N/A	C02	N/A	Jul. 06, 2015
6	Test Cable	N/A	C03	N/A	Jul. 06, 2015
7	EMI Test Receiver	R&S	ESCI	101160	Jul. 06, 2015
8	Passive Voltage Probe	ESH2-Z3	R&S	100196	Jul. 06, 2015
9	Triple-Loop Antenna	EVERFINE	LIA-2	11020003	Jul. 06, 2015
10	Absorbing Clamp	R&S	MDS-21	100423	Jul. 06, 2015

2.5.2 RADIATED TEST SITE

Item	Kind of Equipment	Manufacturer	Type No.	Serial No.	Calibrated until
1	Bilog Antenna	TESEQ	CBL6111D	31216	Jul. 06, 2015
2	Test Cable	N/A	R-01	N/A	Jul. 06, 2015
3	Test Cable	N/A	R-02	N/A	Jul. 06, 2015
4	EMI Test Receiver	R&S	ESCI-7	101318	Jul. 06, 2015
5	Antenna Mast	EM	SC100_1	N/A	N/A
6	Turn Table	EM	SC100	060531	N/A
7	50Ω Switch	Anritsu Corp	MP59B	6200983705	Jul. 06, 2015
8	Spectrum Analyzer	Aglient	E4407B	MY45108040	Jul. 06, 2015
9	Horn Antenna	EM	EM-AH-1018 0	2011071402	Jul. 06, 2015
10	Amplifier	EM	EM-30180	060538	Jul. 06, 2015

2.5.3 HARMONICS AND FILCK

Item	Kind of Equipment	Manufacturer	Type No.	Serial No.	Calibrated until
1	Harmonic & Flicker	EM TEST	DPA500	0303-04	Jul. 06, 2015
2	AC Power Source	EM TEST	ACS500	0203-01	Jul. 06, 2015

2.5.4 ESD

Item	Kind of Equipment	Manufacturer	Type No.	Serial No.	Calibrated until
1	ESD TEST GENERATOR	EVERFINE	EMS61000-2 A-V200	11040001T	Jul. 06, 2015



2.5.5 RS

~	2.3.3 1.6					
	Item	Kind of Equipment	Manufacturer	Type No.	Serial No.	Calibrated until
	1	Signal Generator	R&S	SMT 06	832080/007	Jul. 24, 2015
	2	Log-Bicon Antenna	Schwarzbeck	VULB9161	4022	Aug. 15, 2015
	3	Power Amplifier	AR	150W1000M1	320946	Sep. 23, 2015
	4	Microwave Horn Antenna	AR	AT4002A	321467	Jun. 11, 2015
	5	Power Amplifier	AR	25S1G4A	308598	Sep. 23, 2015

2.5.6 SURGE, EFT/BURST, VOLTAGE INTERRUPTION/DIPS

Item	Kind of Equipment	Manufacturer	Type No.	Serial No.	Calibrated until
1	Surge Generator	EVERFINE	EMS61000-5 A	1101002	Jul. 06, 2015
2	DIPS Generator	EVERFINE	EMS61000-1 1K	1011002	Jul. 06, 2015
3	EFT/B Generator	EVERFINE	EMS61000-4 A-V2	1012005	Aug. 04, 2015

2.5.7 INJECTION CURRENT

Item	Kind of Equipment	Manufacturer	Type No.	Serial No.	Calibrated until
1	Signal Generator	IFR	2023A	202301/368	Mar. 31, 2016
2	Power Amplifier	AR	75A250AM1	0320709	Sep. 23, 2015
3	CDN	FCC	FCC-801-M2	06043	Jun. 02, 2015
4	EM Clamp	FCC	F-203I-23MM	504	Jun. 09, 2015

2.4.8 MF

Item	Kind of Equipment	Manufacturer	Type No.	Serial No.	Calibrated until
1	Generator	EVERFINE	EMS61000-8 K	1007001	Jul. 06, 2015

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3. EMC EMISSION TEST

3.1 CONDUCTED EMISSION MEASUREMENT

3.1.1 POWER LINE CONDUCTED EMISSION

FREQUENCY (MHz)	Quasi-peak	Average
0.009-0.05	110	
0.05-0.15	90 - 80 *	
0.15 -0.5	66 - 56 *	56 - 46 *
0.50 -5.0	56.00	46.00
5.0 -30.0	60.00	50.00

Note:

(1) The tighter limit applies at the band edges.

(2) The limit of " * " marked band means the limitation decreases linearly with the logarithm of the frequency in the range.

3.1.2 LOAD TERMINAL CONDUCTED EMISSION

(Frequency Range 150KHz-30MHz)

FREQUENCY (MHz)	Quasi-peak	Average
0.15 -0.5	80	70
0.50 -30.0	74	64

Note:

(1) The tighter limit applies at the band edges.

3.1.3 CONTROL TERMINAL CONDUCTED EMISSION (Frequency Range

(Frequency Range 150KHz-30MHz)

FREQUENCY (MHz)	Quasi-peak	Average
0.15 -0.5	84 - 74*	74 - 64*
0.50 -30.0	74	64

Note:

(1) The tighter limit applies at the band edges.

(2) The limit of " * " marked band means the limitation decreases linearly with the logarithm of the frequency in the range.

The following table is the setting of the receiver

Setting
10 dB
0.009 MHz
30 MHz
200Hz and 9 kHz

(Frequency Range 9KHz-30MHz)

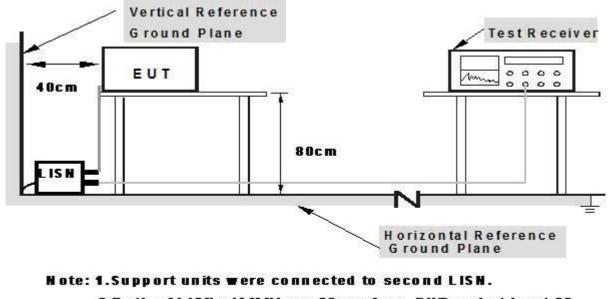
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3.1.4 TEST PROCEDURE

- a. The EUT was placed 0.4 meters from the horizontal ground plane with EUT being connected to the power mains through a line impedance stabilization network (LISN). All other support equipments powered from additional LISN(s). The LISN provide 50 Ohm/ 50uH of coupling impedance for the measuring instrument.
- b. Interconnecting cables that hang closer than 40 cm to the ground plane shall be folded back and forth in the center forming a bundle 30 to 40 cm long.
- c. I/O cables that are not connected to a peripheral shall be bundled in the center. The end of the cable may be terminated, if required, using the correct terminating impedance. The overall length shall not exceed 1 m.
- d. LISN at least 80 cm from nearest part of EUT chassis.
- e. For the actual test configuration, please refer to the related Item –EUT Test Photos.

3.1.5 TEST SETUP



2.Both of LISN's (AMN) are 80 cm from EUT and at least 80 from other units and other metal planes

3.1.6 EUT OPERATING CONDITIONS

The EUT tested system was configured as the statements of **2.3** Unless otherwise a special operating condition is specified in the follows during the testing.



3.1.7 TEST RESULTS

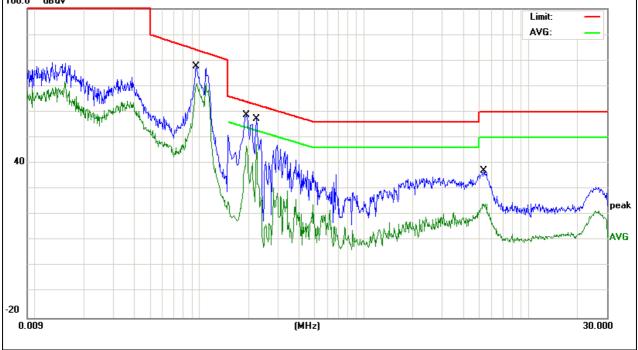
EUT :	led moving head beam light	Model Name. :	LY-390A
Temperature :	26 ℃	Relative Humidity :	54%
Pressure :	1010hPa	Test Date :	2015-05-25
Test Mode :	On	Phase :	L
Test Voltage :			

Freq.	Reading	Factor	Measurement	Limit	Over	Detector
(MHz)	(dBuV)	(dBuV)	(dBuV)	(dBuV)	(dB)	Delector
0.096	62.34	15.33	77.67	84.06	-6.39	QP
0.194	48.35	10.44	58.79	63.86	-5.07	QP
0.222	36.83	10.44	47.27	52.74	-5.47	AVG
5.246	13.69	10.64	24.33	50.00	-25.67	AVG
5.3580	26.65	10.65	37.30	60.00	-22.70	QP

Remark:

- 1. All readings are Quasi-Peak and Average values.
- Factor = Insertion Loss + Cable Loss.
 N/A means All Data have pass Limit

100.0 dBuV



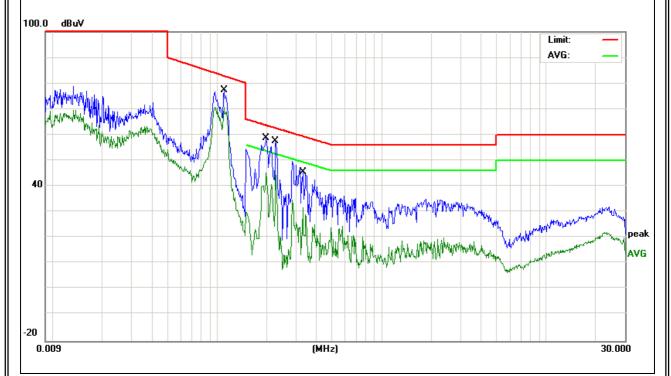


EUT :	led moving head beam light	Model Name. :	LY-390A
Temperature :	26 ℃	Relative Humidity:	54%
Pressure :	1010hPa	Test Date :	2015-05-25
Test Mode :	On	Phase :	Ν
Test Voltage :			

Freq.	Reading	Factor	Measurement	Limit	Over	Detector	
(MHz)	(dBuV)	(dBuV)	(dBuV)	(dBuV)	(dB)	Delector	
0.1097	61.82	15.49	77.31	82.84	-5.53	QP	_
0.198	48.30	10.42	58.72	63.69	-4.97	QP	
0.226	35.94	10.43	46.37	52.59	-6.22	AVG	
0.33	21.44	10.42	31.86	49.45	-17.59	AVG	_

Remark:

All readings are Quasi-Peak and Average values.
 Factor = Insertion Loss + Cable Loss.
 N/A means All Data have pass Limit



3.2 RADIATED EMISSION MEASUREMENT

3.2.1 LIMITS OF RADIATED EMISSION MEASUREMENT (Below 1000MHz)

FREQUENCY (MHz)	🛛 2m	🗌 3m	🗌 4m
	dB(µA)	dB(µA)	dB(µA)
9 KHz~ 70 KHz	88	81	75
70 KHz ~ 150 KHz	88 to 58	81 to 51	75 to 45
150 KHz ~ 3 MHz	58 to 22	51 to 15	45 to 9
3 MHz ~ 30 MHz	22	15 to 16	9 to 12

	At 10m	At 3m	
FREQUENCY (MHz)	dBuV/m	dBuV/m	
30 – 230	30	40	
230 - 300	37	47	

Notes:

(1) The limit for radiated test was performed according to as following: CISPR 15.

(2) The tighter limit applies at the band edges.

(3) Emission level (dBuV/m)=20log Emission level (uV/m).

3.2.2 TEST PROCEDURE

- a. The measuring distance of at 10 m shall be used for measurements at frequency up to 1GHz. For frequencies above 1GHz, any suitable measuring distance may be used.
- b. The EUT was placed on the top of a rotating table 0.8 meters above the ground at a 10 meter open area test site. The table was rotated 360 degrees to determine the position of the highest radiation.
- c. The height of the equipment or of the substitution antenna shall be 0.8 m; the height of the test antenna shall vary between 1 m to 4 m. Both horizontal and vertical polarizations of the antenna are set to make the measurement.
- d. The initial step in collecting conducted emission data is a spectrum analyzer peak detector mode pre-scanning the measurement frequency range. Significant peaks are then marked and then Quasi Peak detector mode re-measured, above 1G Average detector mode will be instead.
- e. If the Peak Mode measured value compliance with and lower than Quasi Peak Mode Limit, the EUT shall be deemed to meet QP(AV) Limits and then no additional QP Mode measurement performed.
- f. For the actual test configuration, please refer to the related Item –EUT Test Photos.

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Page 19 of 61 3.2.3 TEST SETUP (A) Radiated Emission Test Set-Up Frequency Below 30 MHz a 2 m (3×) Equipme (B) Radiated Emission Test Set-Up Frequency Above 30 MHz 3m Turntable 1m to 4m EUT Spectrum 0.8m Analyzer Ground Plane Coaxial Cable

3.2.4 EUT OPERATING CONDITIONS

The EUT tested system was configured as the statements of 2.3 Unless otherwise a special operating condition is specified in the follows during the testing.



3.2.5 TEST RESULTS(30MHz-300MHz)

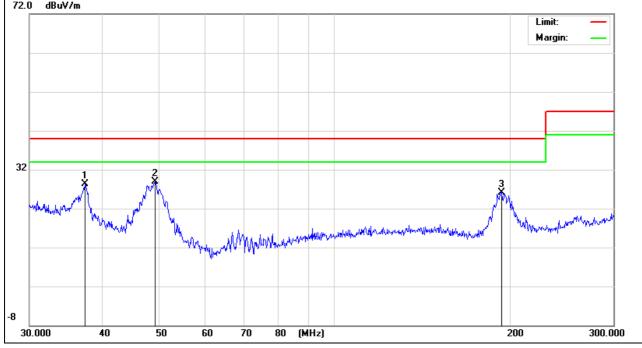
EUT :	led moving head beam light	Model Name. :	LY-390A
Temperature :	24 ℃	Relative Humidity :	54%
Pressure :	1010 hPa	Test Date :	2015-05-25
Test Mode :	On	Polarization :	Horizontal
Test Power :			

Freq.	Reading	Factor	Measurement	Limit	Over	Detector
(MHz)	(dBuV)	(dBuV)	(dBuV)	(dBuV)	(dB)	Delector
37.3354	13.68	14.58	28.26	40	-11.74	QP
49.2177	20.43	8.54	28.97	40	-11.03	QP
192.8063	17.49	8.71	26.2	40	-13.8	QP

Remark:

- 1. All readings are Quasi-Peak and Average values.
- 2. Factor = Antenna Factor + Cable Loss.
- 3. N/A means All Data have pass Limit

72.0 dBu∀/m





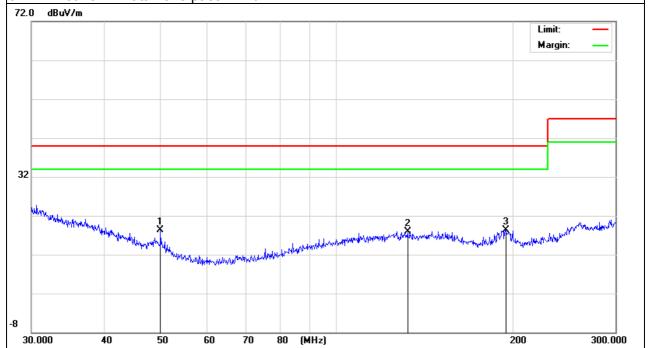
EUT :	led moving head beam light	Model Name. :	LY-390A
Temperature :	24 °C	Relative Humidity :	54%
Pressure :	1010 hPa	Test Date :	2015-05-25
Test Mode :	On	Polarization :	Vertical
Test Power :			

Freq.	Reading	Factor	Measurement	Limit	Over	Detector
(MHz)	(dBuV)	(dBuV)	(dBuV)	(dBuV)	(dB)	Delector
49.9024	10.05	8.22	18.27	40	-21.73	QP
132.1665	5.93	11.94	17.87	40	-22.13	QP
194.5903	9.66	8.69	18.35	40	-21.65	QP

Remark:

All readings are Quasi-Peak and Average values.
 Factor = Antenna Factor + Cable Loss.

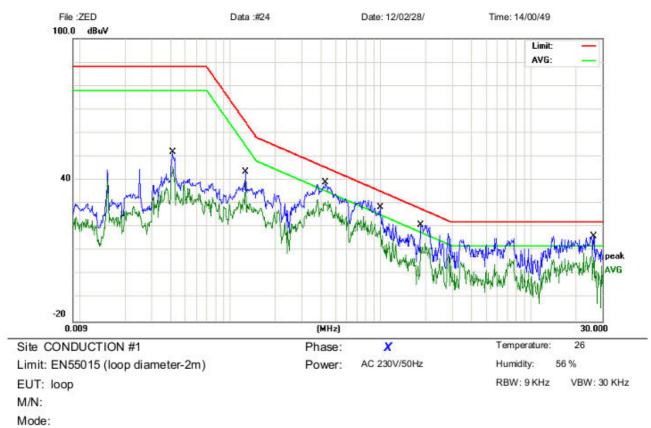
3. N/A means All Data have pass Limit





3.2.6 TEST RESULTS(0.009~30MHz)

EUT :	led moving head beam light	Model Name. :	LY-390A
Temperature :	24 °C	Relative Humidity :	54%
Pressure :	1010 hPa	Test Date :	2015-05-25
Test Mode :	On	Polarization :	Х
Test Power :			



Note:

No.	Mk.	Freq.	Reading Level	Correct Factor	Measure- ment	Limit	Over			
		MHz	dBuV	dB	dBuV	dBuV	dB	Detector	Comment	
1		0.0417	27.83	18.02	45.85	78.00	-32.15	AVG		
2		0.1267	19.23	20.71	39.94	54.62	-14.68	AVG		
3		0.4312	17.62	21.22	38.84	45.31	-6.47	QP		
4	*	0.9943	-1.82	21.89	20.07	25.27	-5.20	AVG		
5		1.8418	-0.38	21.40	21.02	27.86	-6.84	QP		
6	- 8	26.1356	-0.23	16.47	16.24	22.00	-5.76	QP		



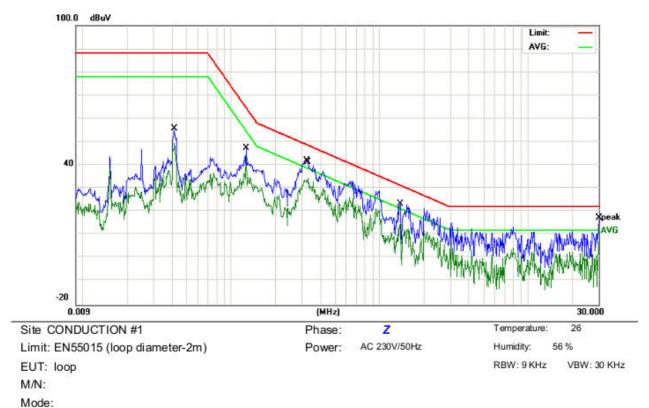
	led moving head beam light	Model Name. :	LY-390A	
mperature :	24 ℃	Relative Humidity :	54%	
essure	1010 hPa	Test Date :	2015-05-25	
st Mode :	On	Polarization :	Y	
st Power :				
100.0 dBuV			Limit: — AVG: —	
40	A A A A A A A A A A A A A A A A A A A		A ATU 11 1	peak
-20 0.009		(MHz)	1444/14/14/14/14/14/14/14/14/14/14/14/14	AVG 0
0.009 Site CONDUCTIO		Phase: Y	30.000 Temperature: 26	
0.009 Site CONDUCTIO Limit: EN55015 (k		1/21/08/572	Temperature: 26 Humidity: 56 %	0
0.009 Site CONDUCTIC Limit: EN55015 (k EUT: loop		Phase: Y	30.000 Temperature: 26	0
0.009 Site CONDUCTIO Limit: EN55015 (k		Phase: Y	Temperature: 26 Humidity: 56 %	0

No. Mk.	Freq.	Reading Level	Correct Factor	Measure- ment	Limit	Over			
	MHz	dBuV	dB	dBuV	dBuV	dB	Detector	Comment	
1	0.0413	36.22	17.99	54.21	88.00	-33.79	QP		
2	0.1267	26.26	20.71	46.97	64.62	-17.65	QP		
3	0.2921	18.15	21.09	39.24	49.98	-10.74	QP		
4	0.0417	29.83	18.02	47.85	78.00	-30.15	AVG		
5	0.7246	2.33	21.36	23.69	29.07	-5.38	AVG		
6 *	2.6967	-12.66	21.55	8.89	13.28	-4.39	AVG		



Report No.: CTB150520002E

EUT :	led moving head beam light	Model Name. :	LY-390A
Temperature :	24 ℃	Relative Humidity :	54%
Pressure :	1010 hPa	Test Date :	2015-05-25
Test Mode :	On	Polarization :	Z
Test Power :			



MICOC.

Note:

No. Mk.	Freq.	Reading Level	Correct Factor	Measure- ment	Limit	Over			
	MHz	dBuV	dB	dBuV	dBuV	dB	Detector	Comment	
1	0.0417	31.33	18.02	49.35	78.00	-28.65	AVG		
2	0.1267	23.23	20.71	43.94	54.62	-10.68	AVG		
3	0.3246	20.89	21.12	42.01	48.72	-6.71	QP		
4 *	0.3326	13.31	21.13	34.44	38.42	-3.98	AVG		
5	1.3754	1.73	21.68	23.41	31.37	-7.96	QP		
6	30.0000	1.81	15.56	17.37	22.00	-4.63	QP		



3.3 HARMONICS CURRENT

β.3.1 LIMITS OF HARMONICS CURRENT

Harmonic Current Test Limit (Class C)

	Maximum permissible harmonic current
Harmonic order	Expressed as a percentage of the input
(n)	Current at the fundamental frequency
	%
2	2
3	30.λ
5	10
7	7
9	5
15≤n≤39	3
(odd harmonics only)	5
Remark: λ is the circuit	power factor

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3.3.1.1TEST PROCEDURE

a. The EUT was placed on the top of a wooden table 0.8 meters above the ground and operated to produce the maximum harmonic components under normal operating conditions.

b. The classification of EUT is according to section 5 of EN 61000-3-2. The EUT is classified as follows:

Class A: Balanced three-phase equipment, Household appliances excluding equipment as Class D, Tools excluding portable tools, Dimmers for incandescent lamps, audio equipment, equipment not specified in one of the three other classes.

Class B: Portable tools. Portable tools.; Arc welding equipment which is not professional equipment.

Class C: Lighting equipment.

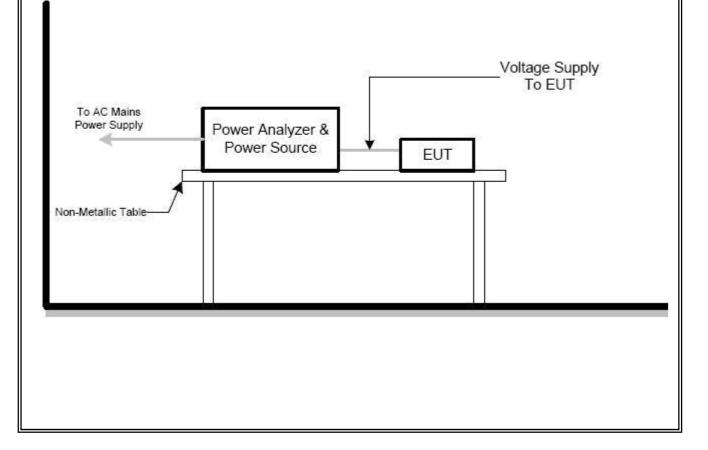
Class D: Equipment having a specified power less than or equal to600 W of the following types: Personal computers and personal computer monitors and television receivers.

c. The correspondent test program of test instrument to measure the current harmonics emanated from EUT is chosen. The measure time shall be not less than the time necessary for the EUT to be exercised.

3.3.1.2 EUT OPERATING CONDITIONS

The EUT tested system was configured as the statements of **2.3** Unless otherwise a special operating condition is specified in the follows during the testing.







3.3.2 TEST RESULTS

EUT :	led moving head beam light	Model Name. :	LY-390A
Temperature :	25 ℃	Relative Humidity :	45%
Pressure :	1010 hPa	Test Date :	2015-05-25
Test Mode :	On		
Test Power :			
	<u>E. U. T</u>	<u>. Result</u>	
Harmonic(s) > 20	00%:		
Ord	er (n): None		
Harmonic(s) with	h average > 90%:		
Ord	er (n): None		
Harmonic(s) bet	ween 150% and 200% during me	ore than 10% of the te	st time or max. 10min:
Ord	er (n): None		
First dataset out			
	(time): None		
Harmonic(s) out			
Ord	er (n): None		



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Hn	leff [A]	leff [%]	Limit [A]	Result
1	32.497E-3	100.000		
2	1.299E-3	3.998	972.00E-3	PASS
3	30.692E-3	94.445	2.07	PASS
4	1.816E-3	5.588	387.00E-3	PASS
5	29.329E-3	90.253	1.03	PASS
6	1.292E-3	3.977	270.00E-3	PASS
7	27.576E-3	84.858	693.00E-3	PASS
8	952.234E-6	2.930	207.00E-3	PASS
9	25.431E-3	78.258	360.00E-3	PASS
10	896.645E-6	2.759	165.60E-3	PASS
11	22.984E-3	70.728	297.00E-3	PASS
12	936.627E-6	2.882	138.00E-3	PASS
13	20.328E-3	62.555	189.00E-3	PASS
14	811.926E-6	2.498	118.29E-3	PASS
15	17.540E-3	53.975	135.00E-3	PASS
16	726.776E-6	2.236	103.50E-3	PASS
17	14.732E-3	45.335	119.11E-3	PASS
18	1.012E-3	3.114	92.00E-3	PASS
19	12.030E-3	37.019	106.58E-3	PASS
20	705.497E-6	2.171	82.80E-3	PASS
21	9.547E-3	29.379	96.43E-3	PASS
22	909.232E-6	2.798	75.28E-3	PASS
23	7.371E-3	22.682	88.05E-3	PASS
24	643.431E-6	1.980	68.99E-3	PASS
25	5.613E-3	17.273	81.00E-3	PASS
26	621.366E-6	1.912	63.69E-3	PASS
27	4.388E-3	13.504	75.00E-3	PASS
28	604.813E-6	1.861	59.14E-3	PASS
29	3.655E-3	11.249	69.83E-3	PASS
30	599.997E-6	1.846	55.20E-3	PASS
31	3.365E-3	10.356	65.32E-3	PASS
32	584.959E-6	1.800	51.75E-3	PASS
33	3.240E-3	9.969	61.36E-3	PASS
34	589.753E-6	1.815	48.71E-3	PASS
35	3.154E-3	9.706	57.86E-3	PASS
36	745.584E-6	2.294	46.00E-3	PASS
37	3.004E-3	9.245	54.73E-3	PASS
38	602.293E-6	1.853	43.58E-3	PASS
39	2.738E-3	8.426	51.92E-3	PASS
40	712.286E-6	2.192	41.40E-3	PASS



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Hn	leff [A]	leff [%]	Limit [A]	Result
1	32.829E-3	100.000		
2	2.053E-3	6.254	2.16	PASS
3	31.136E-3	94.843	4.60	PASS
4	3.390E-3	10.327	860.00E-3	PASS
5	30.083E-3	91.635	2.28	PASS
6	1.778E-3	5.417	600.00E-3	PASS
7	28.240E-3	86.020	1.54	PASS
8	1.451E-3	4.420	460.00E-3	PASS
9	26.091E-3	79.475	800.00E-3	PASS
10	1.393E-3	4.243	368.00E-3	PASS
11	23.548E-3	71.730	660.00E-3	PASS
12	1.215E-3	3.700	306.66E-3	PASS
13	20.749E-3	63.203	420.00E-3	PASS
14	1.094E-3	3.331	262.86E-3	PASS
15	17.851E-3	54.375	300.00E-3	PASS
16	1.036E-3	3.155	230.00E-3	PASS
17	14.934E-3	45.489	264.70E-3	PASS
18	1.292E-3	3.937	204.44E-3	PASS
19	12.201E-3	37.165	236.84E-3	PASS
20	967.940E-6	2.948	184.00E-3	PASS
21	9.662E-3	29.430	214.28E-3	PASS
22	1.174E-3	3.576	167.28E-3	PASS
23	7.515E-3	22.891	195.66E-3	PASS
24	884.520E-6	2.694	153.32E-3	PASS
25	5.762E-3	17.550	180.00E-3	PASS
26	844.765E-6	2.573	141.54E-3	PASS
27	4.499E-3	13.705	166.66E-3	PASS
28	782.868E-6	2.385	131.42E-3	PASS
29	3.756E-3	11.440	155.18E-3	PASS
30	750.699E-6	2.287	122.66E-3	PASS
31	3.476E-3	10.588	145.16E-3	PASS
32	759.436E-6	2.313	115.00E-3	PASS
33	3.429E-3	10.446	136.36E-3	PASS
34	766.301E-6	2.334	108.24E-3	PASS
35	3.396E-3	10.345	128.58E-3	PASS
36	980.017E-6	2.985	102.22E-3	PASS
37	3.248E-3	9.893	121.62E-3	PASS
38	796.979E-6	2.428	96.84E-3	PASS
39	2.981E-3	9.081	115.38E-3	PASS
40	957.699E-6	2.917	92.00E-3	PASS



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Hn	Ueff [V]	Ueff [%]	Limit [%]	Result
1	231.38	100.599		
2	73.71E-3	0.032	0.2	PASS
3	118.14E-3	0.051	0.9	PASS
4	17.60E-3	0.008	0.2	PASS
5	39.89E-3	0.017	0.4	PASS
6	15.11E-3	0.007	0.2	PASS
7	46.20E-3	0.020	0.3	PASS
8	14.51E-3	0.006	0.2	PASS
9	41.06E-3	0.018	0.2	PASS
10	11.32E-3	0.005	0.2	PASS
11	44.90E-3	0.020	0.1	PASS
12	10.67E-3	0.005	0.1	PASS
13	40.80E-3	0.018	0.1	PASS
14	9.95E-3	0.004	0.1	PASS
15	37.21E-3	0.016	0.1	PASS
16	10.53E-3	0.005	0.1	PASS
17	34.50E-3	0.015	0.1	PASS
18	10.00E-3	0.004	0.1	PASS
19	21.94E-3	0.010	0.1	PASS
20	11.21E-3	0.005	0.1	PASS
21	45.11E-3	0.020	0.1	PASS
22	9.99E-3	0.004	0.1	PASS
23	20.80E-3	0.009	0.1	PASS
24	14.25E-3	0.006	0.1	PASS
25	18.43E-3	0.008	0.1	PASS
26	10.98E-3	0.005	0.1	PASS
27	21.66E-3	0.009	0.1	PASS
28	11.93E-3	0.005	0.1	PASS
29	40.50E-3	0.018	0.1	PASS
30	10.68E-3	0.005	0.1	PASS
31	19.94E-3	0.009	0.1	PASS
32	10.30E-3	0.004	0.1	PASS
33	17.33E-3	0.008	0.1	PASS
34	10.45E-3	0.005	0.1	PASS
35	18.79E-3	0.008	0.1	PASS
36	10.45E-3	0.005	0.1	PASS
37	28.09E-3	0.012	0.1	PASS
38	9.74E-3	0.004	0.1	PASS
39	24.44E-3	0.011	0.1	PASS
40	12.46E-3	0.005	0.1	PASS



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Report No.: CTB150520002E

Hn	leff [A]	leff [%]	Limit [A]	Result
1	32.561E-3	100.000		
2	1.407E-3	4.323	1.08	PASS
3	30.902E-3	94.905	2.30	PASS
4	2.826E-3	8.680	430.00E-3	PASS
5	30.071E-3	92.353	1.14	PASS
6	1.277E-3	3.922	300.00E-3	PASS
7	28.178E-3	86.539	770.00E-3	PASS
8	1.004E-3	3.082	230.00E-3	PASS
9	26.049E-3	80.001	400.00E-3	PASS
10	900.316E-6	2.765	184.00E-3	PASS
11	23.490E-3	72.140	330.00E-3	PASS
12	915.808E-6	2.813	153.33E-3	PASS
13	20.748E-3	63.720	210.00E-3	PASS
14	793.970E-6	2.438	131.43E-3	PASS
15	17.851E-3	54.822	150.00E-3	PASS
16	745.497E-6	2.290	115.00E-3	PASS
17	14.902E-3	45.765	132.35E-3	PASS
18	1.193E-3	3.663	102.22E-3	PASS
19	12.094E-3	37.143	118.42E-3	PASS
20	693.706E-6	2.130	92.00E-3	PASS
21	9.510E-3	29.206	107.14E-3	PASS
22	1.132E-3	3.477	83.64E-3	PASS
23	7.315E-3	22.465	97.83E-3	PASS
24	668.640E-6	2.053	76.66E-3	PASS
25	5.512E-3	16.928	90.00E-3	PASS
26	662.294E-6	2.034	70.77E-3	PASS
27	4.305E-3	13.222	83.33E-3	PASS
28	649.062E-6	1.993	65.71E-3	PASS
29	3.618E-3	11.112	77.59E-3	PASS
0	632.252E-6	1.942	61.33E-3	PASS
31	3.444E-3	10.577	72.58E-3	PASS
32	608.284E-6	1.868	57.50E-3	PASS
33	3.323E-3	10.206	68.18E-3	PASS
34	573.288E-6	1.761	54.12E-3	PASS
35	3.273E-3	10.052	64.29E-3	PASS
36	928.190E-6	2.851	51.11E-3	PASS
37	3.171E-3	9.738	60.81E-3	PASS
38	606.135E-6	1.862	48.42E-3	PASS
39	2.797E-3	8.589	57.69E-3	PASS
40	916.792E-6	2.816	46.00E-3	PASS

Caution: Results related to the 100% limit values



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Hn	Ueff [V]	Ueff [%]	Limit [%]	Result
1	231.37	100.594		
2	56.61E-3	0.025	0.2	PASS
3	98.20E-3	0.043	0.9	PASS
4	6.66E-3	0.003	0.2	PASS
5	35.37E-3	0.015	0.4	PASS
6	6.01E-3	0.003	0.2	PASS
7	38.57E-3	0.017	0.3	PASS
8	599.76E-6	0.000	0.2	PASS
9	32.03E-3	0.014	0.2	PASS
10	9.29E-3	0.004	0.2	PASS
11	30.48E-3	0.013	0.1	PASS
12	4.31E-3	0.002	0.1	PASS
13	34.38E-3	0.015	0.1	PASS
14	3.40E-3	0.001	0.1	PASS
15	30.32E-3	0.013	0.1	PASS
6	2.68E-3	0.001	0.1	PASS
17	30.97E-3	0.013	0.1	PASS
18	5.19E-3	0.002	0.1	PASS
9	11.73E-3	0.005	0.1	PASS
20	8.01E-3	0.003	0.1	PASS
21	41.84E-3	0.018	0.1	PASS
22	3.10E-3	0.001	0.1	PASS
23	11.97E-3	0.005	0.1	PASS
24	2.73E-3	0.001	0.1	PASS
25	13.32E-3	0.006	0.1	PASS
26	4.32E-3	0.002	0.1	PASS
7	10.01E-3	0.004	0.1	PASS
28	4.48E-3	0.002	0.1	PASS
29	33.31E-3	0.014	0.1	PASS
0	2.35E-3	0.001	0.1	PASS
31	13.06E-3	0.006	0.1	PASS
32	5.47E-3	0.002	0.1	PASS
33	16.34E-3	0.007	0.1	PASS
34	2.67E-3	0.001	0.1	PASS
35	16.24E-3	0.007	0.1	PASS
36	1.18E-3	0.001	0.1	PASS
37	22.01E-3	0.010	0.1	PASS
38	4.85E-3	0.002	0.1	PASS
39	14.27E-3	0.006	0.1	PASS
40	4.35E-3	0.002	0.1	PASS

Power and THD results - DS: 22				
True power P:	433.8W	Apparent power S:	453VA	
Reactiv power Q:	16.81var	Power factor:	0.904	
THD (U):	0.001	THD (I):	2.207	
Crest Factor (U):	1.414	Crest Factor (I):	4.549	



β.4 VOLTAGE FLUCTUATION AND FLICKERS

β.4.1 LIMITS OF VOLTAGE FLUCTUATION AND FLICKERS

Tests	Limits		Descriptions	
Tesis	IEC555-3	IEC/EN 61000-3-3	Descriptions	
Pst	≤ 1.0, Tp= 10 min.	≤ 1.0, Tp= 10 min.	Short Term Flicker Indicator	
Plt	N/A	≤ 0.65, Tp=2 hr.	Long Term Flicker Indicator	
dc	≤ 3 %	≤ 3.3%	Relative Steady-State V-Chang	
dmax	$\leq 4\%$	$\leq 4\%$	Maximum Relative ∨-change	
d (t)	N/A	$\leq 3.3\%$ for $> 500~ms$	Relative V-change characteristic	

3.4.1.1TEST PROCEDURE

a. Harmonic Current Test:

Test was performed according to the procedures specified in Clause 5.0 of IEC555-2 and/or Sub-clause 6.2 of IEC/EN 61000-3-2 depend on which standard adopted for compliance measurement.

b. Fluctuation and Flickers Test:

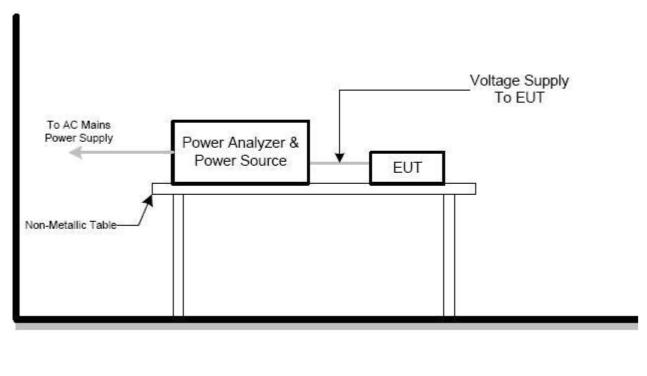
Tests was performed according to the Test Conditions/Assessment of Voltage Fluctuations specified in Clause 5.0/6.0 of IEC555-3 and/or Clause 6.0/4.0 of IEC/EN 61000-3-3 depend on which standard adopted for compliance measurement.

c. All types of harmonic current and/or voltage fluctuation in this report are assessed by direct measurement using flicker-meter.

3.4.1.2 EUT OPERATING CONDITIONS

The EUT tested system was configured as the statements of **2.3** Unless otherwise a special operating condition is specified in the follows during the testing.

3.4.1.3 TEST SETUP





β.4.2 TEST RESULTS

EUT:	led moving head beam light	Model Name. :	LY-390A
Temperature :	25 ℃	Relative Humidity :	45%
Pressure :	1010 hPa	Test Date :	2015-05-25
Test Mode :	On		
Test Power :			

Maximum Flicker results

	EUT values	Limit	Result
Pst	0.028	1.00	PASS
Plt	0.028	0.65	PASS
dc [%]	0.004	3.30	PASS
dmax [%]	0.170	7.00	PASS
dt [s]	0.000	0.50	PASS

4. EMC IMMUNITY TEST

4.1 STANDARD COMPLIANCE/SERVRITY LEVEL/CRITERIA

Tests Standard No.	TEST SPECIFICATION Level	Test Mode Test Ports	Perform. Criteria
1. ESD IEC/EN 61000-4-2	8KV air discharge 4KV contact discharge	Direct Mode	В
	4KV HCP discharge 4KV VCP discharge	Indirect Mode	В
2. RS IEC/EN 61000-4-3	80 MHz to 1000 MHz 1000Hz, 80%, AM modulated	Enclosure	А
3. EFT/Burst	5/50ns Tr/Th 5KHz Repetition Freq.	Power Supply Port	В
IEC/EN 61000-4-4	5/50ns Tr/Th 5KHz Repetition Freq.	CTL/Signal Data Line Port	В
4. Surges	1.2/50(8/20) Tr/Th us	L-N	В
IEC/EN 61000-4-5	1.2/50(8/20) Tr/Th us	L-PE N-PE	В
	0.15 MHz to 80 MHz, 1000Hz 80%, AM Modulated 150Ω source impedance	CTL/Signal Port	A
5 Injected Current IEC/EN 61000-4-6	0.15 MHz to 80 MHz, 1000Hz 80%, AM Modulated 150Ω source impedance	AC Power Port	A
	0.15 MHz to 80 MHz, 1000Hz 80%, AM Modulated 150Ω source impedance	DC Power Port	А
6. Power Frequency Magnetic Field IEC/EN 61000-4-8	50 Hz,	Enclosure	А
7. Volt. Interruptions Volt. Dips IEC/EN 61000-4-11	Voltage dip 100% Voltage dip 30%	AC Power Port	B C



4.2 GENERAL PERFORMANCE CRITERIA

According to EN 61547 standard, the general performance criteria as following:

 Criterion A The equipment shall continue to operate as intended without operator intervention. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer when the equipment is used as intended. Criterion A The performance level may be replaced by a permissible loss of performance. If the minimum performance level or the permissible performance loss is not specified by the manufacturer, then either of these may be derived from the product description and documentation, and by what the user may reasonably expect from the equipment if used as intended. After the test, the equipment shall continue to operate as intended without operator intervention. No degradation of performance or loss of function is allowed, after the application of the phenomena below a performance level specified by the manufacturer, when the equipment is used as intended. The performance level may be replaced by a permissible loss of performance level specified by the manufacturer, when the equipment is used as intended. The performance level may be replaced by a permissible loss of performance. During the test, degradation of performance is allowed. However, no change of operating state or stored data is allowed to persist after the test. Loss of function is allowed, provided the function is self-recoverable, or can be restored by the operation of the controls by the user in accordance with the manufacturer's instructions. Functions, and/or information stored in non-volatile memory, or protected by a battery backup, shall not be lost. 		
Criterion Aa performance level specified by the manufacturer when the equipment is used as intended. The performance level may be replaced by a permissible loss of performance. If the minimum performance level or the permissible performance loss is not specified by the manufacturer, then either of these may be derived from the product description and documentation, and by what the user may reasonably expect from the equipment if used as intended.Criterion BAfter the test, the equipment shall continue to operate as intended without operator intervention. No degradation of performance or loss of function is allowed, after the application of the phenomena below a performance level specified by the manufacturer, when the equipment is used as intended. The performance level may be replaced by a permissible loss of performance. During the test, degradation of performance is allowed. However, no change of operating state or stored data is allowed to persist after the test. Loss of function is allowed, provided the function is self-recoverable, or can be restored by the operation of the controls by the user in accordance with the manufacturer's instructions. Functions, and/or information stored in non-volatile memory, or protected by a 		
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• • •	Criterion C	

4.3 GENERAL PERFORMANCE CRITERIA TEST SETUP

The EUT tested system was configured as the statements of **2.3** Unless otherwise a special operating condition is specified in the follows during the testing.

4.4 ESD TESTING

4.4.1 TEST SPECIFICATION

Basic Standard:	IEC/EN 61000-4-2
Discharge Impedance:	330 ohm / 150 pF
Required Performance	В
Discharge Voltage:	Air Discharge:2kV/4kV/8kV (Direct)
	Contact Discharge : 2kV/4kV (Direct/Indirect)
Polarity:	Positive & Negative
Number of Discharge:	Air Discharge: min. 20 times at each test point
	Contact Discharge: min. 200 times in total
Discharge Mode:	Single Discharge
Discharge Period:	1 second minimum

4.4.2 TEST PROCEDURE

The test generator necessary to perform direct and indirect application of discharges to the EUT in the following manner:

a. Contact discharge was applied to conductive surfaces and coupling planes of the EUT. During the test, it was performed with single discharges. For the single discharge time between successive single discharges was at least 1 second. The EUT shall be exposed to at least 200 discharges, 100 each at negative and positive polarity, at a minimum of four test points. One of the test points shall be subjected to at least 50 indirect discharges to the center of the front edge of the horizontal coupling plane. The remaining three test points shall each receive at least 50 direct contact discharges.

If no direct contact test points are available, then at least 200 indirect discharges shall be applied in the indirect mode. Test shall be performed at a maximum repetition rate of one discharge per second.

Vertical Coupling Plane (VCP):

The coupling plane, of dimensions $0.5m \ge 0.5m$, is placed parallel to, and positioned at a distance 0.1m from, the EUT, with the Discharge Electrode touching the coupling plane. The four faces of the EUT will be performed with electrostatic discharge.

Horizontal Coupling Plane (HCP):

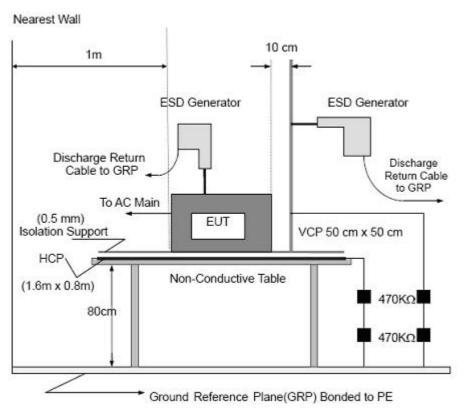
The coupling plane is placed under to the EUT. The generator shall be positioned vertically at a distance of 0.1m from the EUT, with the Discharge Electrode touching the coupling plane. The four faces of the EUT will be performed with electrostatic discharge.

b. Air discharges at insulation surfaces of the EUT.

It was at least ten single discharges with positive and negative at the same selected point.



4.4.3 TEST SETUP



Note:

TABLE-TOP EQUIPMENT

The configuration consisted of a wooden table 0.8 meters high standing on the Ground Reference Plane. The GRP consisted of a sheet of aluminum at least 0.25mm thick, and 2.5 meters square connected to the protective grounding system. A Horizontal Coupling Plane (1.6m x 0.8m) was placed on the table and attached to the GRP by means of a cable with 940k total impedance. The equipment under test, was installed in a representative system as described in section 7 of IEC /EN 61000-4-2, and its cables were placed on the HCP and isolated by an insulating support of 0.5mm thickness. A distance of1-meter minimum was provided between the EUT and the walls of the laboratory and any other metallic structure.

FLOOR-STANDING EQUIPMENT

The equipment under test was installed in a representative system as described in section 7 of IEC/EN 61000-4-2, and its cables were isolated from the Ground Reference Plane by an insulating support of0.1-meter thickness. The GRP consisted of a sheet of aluminum that is at least 0.25mm thick, and 2.5meters square connected to the protective grounding system and extended at least 0.5 meters from the EUT on all sides.



4.4.4 TEST RESULTS

		led moving head beam light Model Name. : LY-390A																
EUT :				ng r	ieac	bea	am I	ight		Model Name. : LY-390. Relative Humidity : 45%				A				
Temperature :	1	25 °(2						F	Rela	tive	Hur	nidit	y:	45%	Ď		
Pressure :		1010) hP	а					٦	Fest	Dat	e :			201	5-05	5-25	
Test Mode :		On																
Test Power :																		
Mode			Air	Dis	cha	rge				C	onta	act D	Disc	harg	е			
Test level (kV)		4	8	3	1	0	1	5	2		4	4	(6	8	3	Criterion	Result
Test Location	+	-	+	-	+	-	+	-	+	-	+	-	+	-	+	-		
HCP									А	А	А	А						PASS
VCP									А	А	А	А						PASS
enclosure	А	А	А	А					А	А	А	А						PASS
																	В	
	L																1	

Note:

1) +/- denotes the Positive/Negative polarity of the output voltage.

2) Test condition:

Direct / Indirect (HCP/VCP) discharges: Minimum 50 times (Positive/Negative) at each point. Air discharges: Minimum 10 times (Positive/Negative) at each point.

3) Test location(s) in which discharge (Air and contact discharge) to be applied illustrated by photos shown in next page(s)

4) The Indirect (HCP/VCP) discharges description of test point as following: 1.left side 2.right side 3.front side 4.rear side

5) N/A - denotes test is not applicable in this test report

4.5 RS TESTING

4.5.1 TEST SPECIFICATION

Basic Standard:	IEC/EN 61000-4-3
Required Performance	Α
Frequency Range:	80 MHz - 1000 MHz
Field Strength:	3 V/m
Modulation:	1kHz Sine Wave, 80%, AM Modulation
Frequency Step:	1 % of fundamental
Polarity of Antenna:	Horizontal and Vertical
Test Distance:	3 m
Antenna Height:	1.5 m
Dwell Time:	at least 3 seconds

4.5.2 TEST PROCEDURE

The EUT and support equipment, which are placed on a table that is 0.8 meter above ground and the testing was performed in a fully-anechoic chamber.

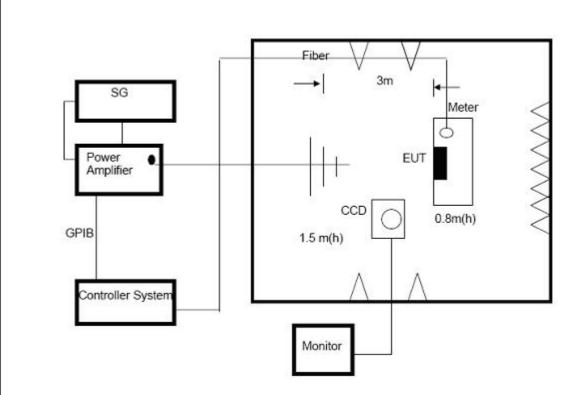
The testing distance from antenna to the EUT was 3 meters.

The other condition as following manner:

- a. The frequency range is swept from 80 MHz to 1000 MHz, & 1400MHz 2700MHz with the signal 80% amplitude modulated with a 1kHz sine wave. The rate of sweep did not exceed 1.5x 10-3 decade/s. Where the frequency range is swept incrementally, the step size was 1% of fundamental.
- b. Sweep Frequency 900 MHz, with the Duty Cycle:1/8 and Modulation: Pulse 217 Hz(if applicable)
- c. The dwell time at each frequency shall be not less than the time necessary for the EUT to be able to respond.
- d. The test was performed with the EUT exposed to both vertically and horizontally polarized fields on each of the four sides.

CTB <u>环测威检测</u>

4.5.3 TEST SETU



Note:

TABLE-TOP EQUIPMENT

The EUT installed in a representative system as described in section 7 of IEC/EN 61000-4-3 was placed on a non-conductive table 0.8 meters in height. The system under test was connected to the power and signal wire according to relevant installation instructions.

FLOOR-STANDING EQUIPMENT

The EUT installed in a representative system as described in section 7 of IEC/EN 61000-4-3 was placed on a non-conductive wood support 0.1 meters in height. The system under test was connected to the power and signal wire according to relevant installation instructions.



4.5.4 TEST RESULTS

EUT :	led moving head beam light	Model Name. :	LY-390A
Temperature :	25 ℃	Relative Humidity :	60%
Pressure :	1010 hPa	Test Date :	2015-05-25
Test Mode :	On		
Test Power :			

Frequency Range (MHz)	RF Field Position	R.F. Field Strength	Azimuth	Perform. Criteria	Results	Judgment
			Front			
80MU- 1000MU-		3 V/m (rms)	Rear	•	•	DASS
80MHz - 1000MHz	H/V	AM Modulated 1000Hz, 80%	Left	A	Α	PASS
			Right			

Note:

1) N/A - denotes test is not applicable in this test report.

2) Criteria A: There was no change operated with initial operating during the test.

3) Criteria B: The EUT function loss during the test, but self-recoverable after the test.

4.6 EFT/BURST TESTING

4.6.1 TEST SPECIFICATION

Basic Standard:	IEC/EN 61000-4-4
Required Performance	В
Test Voltage:	Power Line:1 kV
	Signal/Control Line:0.5 KV
Polarity:	Positive & Negative
Impulse Frequency:	5 kHz
Impulse Wave shape :	5/50 ns
Burst Duration:	15 ms
Burst Period:	300 ms
Test Duration:	Not less than 1 min.

4.6.2 TEST PROCEDURE

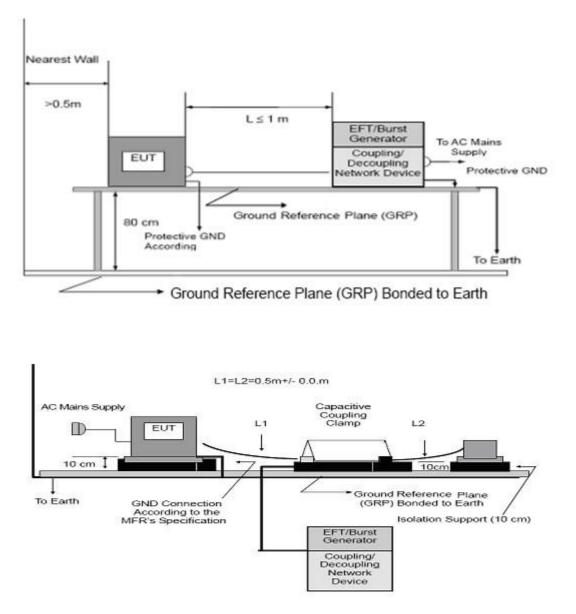
The EUT and support equipment, are placed on a table that is 0.8 meter above a metal ground plane measured 1m*1m min. and 0.65mm thick min.

The other condition as following manner:

- a. The length of power cord between the coupling device and the EUT should not exceed 1 meter.
- b. Both positive and negative polarity discharges were applied.
- c. The duration time of each test sequential was 1 minute



4.6.3 TEST SETUP



Note:

TABLE-TOP EQUIPMENT

The configuration consisted of a wooden table (0.8m high) standing on the Ground Reference Plane. The GRP consisted of a sheet of aluminum (at least 0.25mm thick and 2.5m square) connected to the protective grounding system. A minimum distance of 0.5m was provided between the EUT and the walls of the laboratory or any other metallic structure.

FLOOR-STANDING EQUIPMENT

The EUT installed in a representative system as described in section 7 of IEC/EN 61000-4-4 and its cables, were isolated from the Ground Reference Plane by an insulating support that is 0.1-meter thick. The GRP consisted of a sheet of aluminum (at least 0.25mm thick and 2.5m square) connected to the protective grounding system.



4.6.4 TEST RESULTS

EUT :	led moving head beam light	Model Name. :	LY-390A
Temperature :	25 ℃	Relative Humidity :	60%
Pressure :	1010 hPa	Test Date :	2015-05-25
Test Mode :	On		
Test Power :			

Cou	Ipling Line	0	.5		1	2		4	4	Criterion	Result
		+	-	+	-	+	-	+	-		
	L	А	А	А	А						PASS
	N	А	А	А	А						PASS
AC	PE										N/A
line	L+N	А	А	А	А						PASS
	L+PE									В	N/A
	N+PE										N/A
	L+N+PE										N/A
C	OC Line										
Sig	gnal Line										

Note:

1) +/- denotes the Positive/Negative polarity of the output voltage.

2) N/A - denotes test is not applicable in this test report

3) Criteria A: There was no change operated with initial operating during the test.

4) Criteria B: The EUT function loss during the test, but self-recoverable after the test.

4.7 SURGE TESTING

4.7.1 TEST SPECIFICATION

Basic Standard:	IEC/EN 61000-4-5
Required Performance	В
Wave-Shape:	Combination Wave
	1.2/50 us Open Circuit Voltage
	8 /20 us Short Circuit Current
Test Voltage:	Power Line : 0.5 kV, 1 kV, 2 kV
Surge Input/Output:	L-N, L-PE, N-PE
Generator Source:	2 ohm between networks
Impedance:	12 ohm between network and ground
Polarity:	Positive/Negative
Phase Angle:	0 /90/180/27 0°
Pulse Repetition Rate:	1 time / min. (maximum)
Number of Tests:	5 positive and 5 negative at selected points

4.7.2 TEST PROCEDURE

a. For EUT power supply:

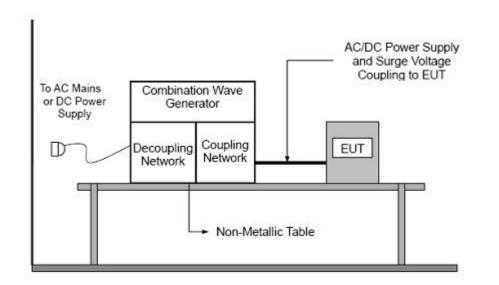
The surge is to be applied to the EUT power supply terminals via the capacitive coupling network. Decoupling networks are required in order to avoid possible adverse effects on equipment not under test that may be powered by the same lines, and to provide sufficient decoupling impedance to the surge wave. The power cord between the EUT and the coupling/decoupling networks shall be 2meters in length (or shorter).

- b. For test applied to unshielded unsymmetrically operated interconnection lines of EUT: The surge is applied to the lines via the capacitive coupling. The coupling /decoupling networks shall not influence the specified functional conditions of the EUT. The interconnection line between the EUT and the coupling/decoupling networks shall be 2 meters in length (or shorter).
- c. For test applied to unshielded symmetrically operated interconnection /telecommunication lines of EUT:
- d. The surge is applied to the lines via gas arrestors coupling. Test levels below the ignition point of the coupling arrestor cannot be specified. The interconnection line between the EUT and the coupling/decoupling networks shall be 2 meters in length (or shorter).



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4.7.3 TEST SETUP





4.7.4 TEST RESULTS

EUT :	led moving head beam light	Model Name. :	LY-390A
Temperature :	25 ℃	Relative Humidity :	60%
Pressure :	1010 hPa	Test Date :	2015-05-25
Test Mode :	On		
Test Power :			

				Test level								
Co	oupling	Line	0.5 kV		/ 1 kV		2 kV		4	4 kV C		Result
			+	-	+	-	+	-	+	-		
		0°	А	А	В	В						
	L-N	90°	А	А	В	В						PASS
		180°	А	А	В	В						1700
		270°	А	А	В	В						
		0°										
AC	L-PE	90°									В	N/A
line		180°										IN/A
		270°										
		0°										
	N-PE	90°										N/A
		180°										
		270°										
	DC Lin	e										
5	Signal Li	ine										

Note:

1) Polarity and Numbers of Impulses : 5 Pst / Ngt at each tested mode

2) N/A - denotes test is not applicable in this Test Report

3) Criteria A: There was no change operated with initial operating during the test.

4) Criteria B: The EUT function loss during the test, but self-recoverable after the test.

4.8 INJECTION CURRENT TESTING

4.8.1 TEST SPECIFICATION

Basic Standard:	IEC/EN 61000-4-6
Required Performance	А
Frequency Range:	0.15 MHz - 80 MHz
Field Strength:	3 Vr.m.s.
Modulation:	1kHz Sine Wave, 80%, AM Modulation
Frequency Step:	1 % of fundamental
Dwell Time:	at least 3 seconds

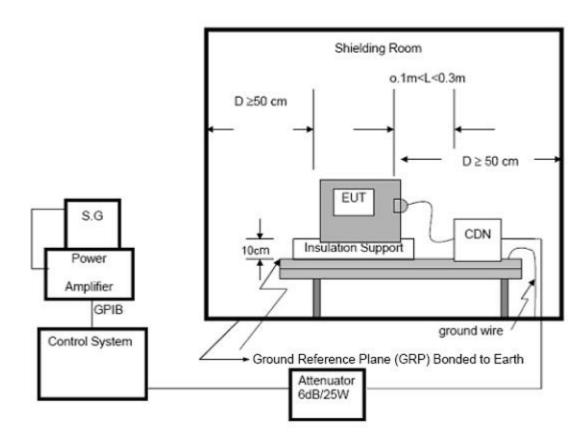
4.8.2 TEST PROCEDURE

The EUT and support equipment, are placed on a table that is 0.8 meter above a metal ground plane measured 1m*1m min. and 0.65mm thick min.

The other condition as following manner:

- a. The frequency range is swept from 150 KHz to 80 MHz, with the signal 80% amplitude modulated with a 1kHz sine wave. The rate of sweep did not exceed 1.5x 10-3 decade/s. Where the frequency range is swept incrementally, the step size was 1% of fundamental.
- b. The dwell time at each frequency shall be not less than the time necessary for the EUT to be able to respond.

4.8.3 TEST SETUP



NOTE:

FLOOR-STANDING EQUIPMENT

The equipment to be tested is placed on an insulating support of 0.1 meters height above a ground reference plane. All relevant cables shall be provided with the appropriate coupling and decoupling devices at a distance between 0.1 meters and 0.3 meters from the projected geometry of the EUT on the ground reference plane.



4.8.4 TEST RESULTS

EUT :	led moving head beam light	Model Name. :	LY-390A
Temperature :	25 ℃	Relative Humidity :	60%
Pressure :	1010 hPa	Test Date :	2015-05-25
Test Mode :	On		
Test Power :			

Test Ports (Mode)	Freq. Range MHz)	Field Strength	Perform. Criteria	Results	Judgment
Input/ Output AC. Power Port	0.1580	2) ((rma)	Α	Α	PASS
Input/ Output DC. Power Port	0.15 80	3V(rms) AM Modulated	Α	N/A	PASS
Signal Line	0.15 80	1000Hz, 80%	Α	N/A	PASS

Note:

1) N/A - denotes test is not applicable in this Test Report.

2) Criteria A: There was no change operated with initial operating during the test.

3) Criteria B: The EUT function loss during the test, but self-recoverable after the test.

4.9 POWER FREQUENCY MAGNETIC FIELD TESTING

4.9.1 TEST SPECIFICATION

Basic Standard:	IEC/EN 61000-4-8
Required Performance	А
Frequency Range:	50Hz
Field Strength:	3 A/m
Observation Time:	1 minute
Inductance Coil:	Rectangular type, 1mx1m

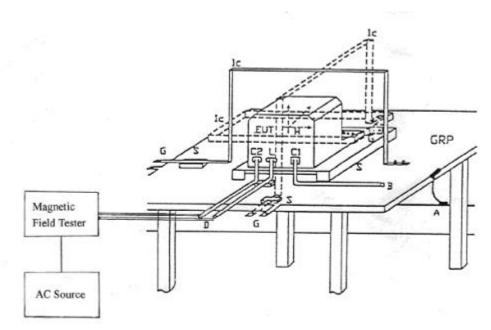
4.9.2 TEST PROCEDURE

The EUT and support equipment, are placed on a table that is 0.8 meter above a metal ground plane measured 1m*1m min. and 0.65mm thick min. The other condition as following manner:

- a. The equipment cabinets shall be connected to the safety earth directly on the GRP via the earth terminal of the EUT.
- b. The cables supplied or recommended by the equipment manufacturer shall be used. 1 meter of all cables used shall be exposed to the magnetic field.



4.9.3 TEST SETUP



Note:

TABLE-TOP EQUIPMENT

The equipment shall be subjected to the test magnetic field by using the induction coil of standard dimension (1 m x 1 m). The induction coil shall then be rotated by 90 degrees in order to expose the EUT to the test field with different orientations.

FLOOR-STANDING EQUIPMENT

The equipment shall be subjected to the test magnetic field by using induction coils of suitable dimensions. The test shall be repeated by moving and shifting the induction coils, in order to test the whole volume of the EUT for each orthogonal direction. The test shall be repeated with the coil shifted to different positions along the side of the EUT, in steps corresponding to 50 % of the shortest side of the coil. The induction coil shall then be rotated by 90 degrees in order to expose the EUT to the test field with different orientations.



4.9.4 TEST RESULTS

EUT :	led moving head beam light	Model Name. :	LY-390A
Temperature :	25 ℃	Relative Humidity :	60%
Pressure :	1010 hPa	Test Date :	2015-05-25
Test Mode :	On		
Test Power :			

Test Mode	Test Level	Antenna aspect	Duration (s)	Perform Criteria	Results	Judgment
Enclosure	3 A/m	Х	60 s	Α	Α	PASS
Enclosure	3 A/m	Y	60 s	Α	Α	PASS
Enclosure	3 A/m	Z	60 s	Α	Α	PASS

Note:

1) N/A - denotes test is not applicable in this test report

2) Criteria A: There was no change operated with initial operating during the test.

3) Criteria B: The EUT function loss during the test, but self-recoverable after the test.

4.10 VOLTAGE INTERRUPTION/DIPS TESTING

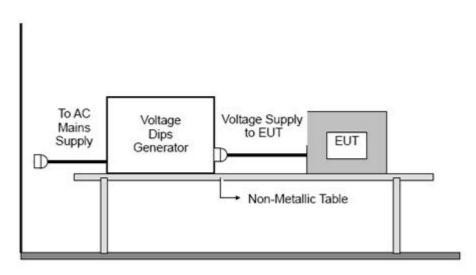
4.10.1 TEST SPECIFICATION

Basic Standard:	IEC/EN 61000-4-11	
Required Performance	B (For 100% Voltage Dips)	
	C (For 30% Voltage Dips)	
Test Duration Time:	Minimum three test events in sequence	
Interval between Event:	Minimum ten seconds	
Phase Angle:	0°/45°/90°/135°/180°/225°/270°/315°/360°	
Test Cycle:	3 times	

4.10.2 TEST PROCEDURE

The EUT shall be tested for each selected combination of test levels and duration with a sequence of three dips/interruptions with intervals of 10 s minimum (between each test event). Each representative mode of operation shall be tested. Abrupt changes in supply voltage shall occur at zero crossings of the voltage waveform.

4.10.3 TEST SETUP





4.10.4 TEST RESULTS

EUT :	led moving head beam light	Model Name. :	LY-390A
Temperature :	25 ℃	Relative Humidity :	60%
Pressure :	1010 hPa	Test Date :	2015-05-25
Test Mode :	On		
Test Power :			

Interruption & Dips	Duration (T)	Perform Criteria	Results	Judgment
Voltage dip 100%	0.5	В	В	PASS
Voltage dip 30%	10	С	В	PASS

Note:

- 1). N/A denotes test is not applicable in this test report.
- 2) Criteria A: There was no change operated with initial operating during the test.
- 3) Criteria B: The EUT function loss during the test, but self-recoverable after the test.
- 4) Criteria C: The system shut down during the test.

5. EUT TEST PHOTO



ATTACHMENT PHOTOGRAPHS OF EUT

Photo 1



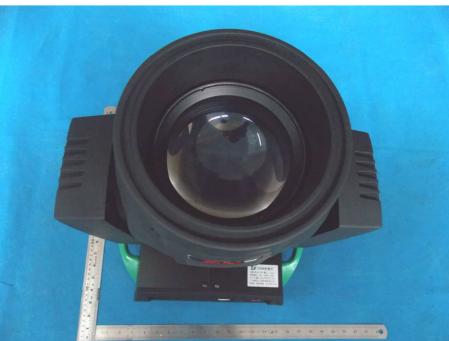


Photo 2



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Photo 3



Photo 4

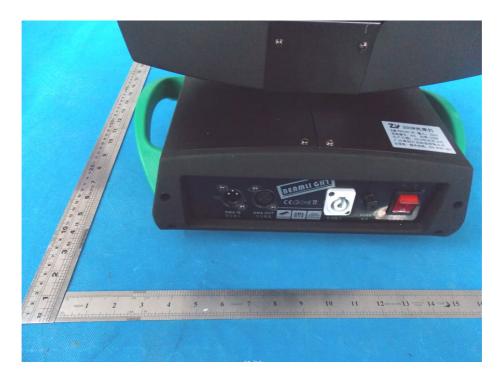




Photo 5



Photo 6





Photo 7

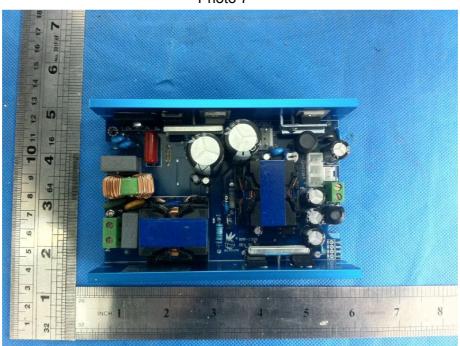


Photo 8

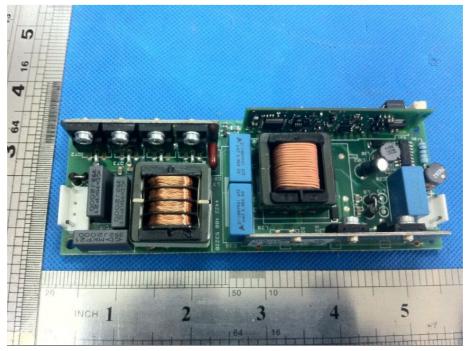




Photo 9



Photo 10

